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STF9N60M2

Datasheet - production data

N-channel 600 V, 0.72 Ω typ., 5.5 A MDmesh II Plus™ low Q_g Power MOSFET in a TO-220FP package

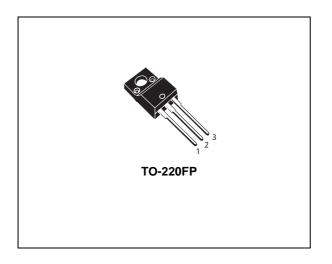
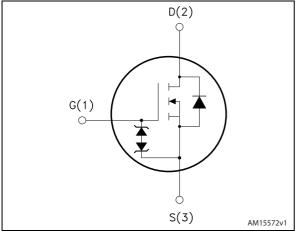


Figure 1. Internal schematic diagram



Features

Order code	V _{DS} @ T _{Jmax}	R _{DS(on)} max	I _D
STF9N60M2	650 V	0.78 Ω	5.5 A

- Extremely low gate charge
- Lower R_{DS(on)} x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

Applications

• Switching applications

Description

This device is an N-channel Power MOSFET developed using a new generation of MDmesh[™] technology: MDmesh II Plus[™] low Q_g. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

Table 1. Device summary

Order code	Marking	Package	Packaging
STF9N60M2	9N60M2	TO-220FP	Tube

DocID024728 Rev 1

This is information on a product in full production.

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1 Electrical ratings

Symbol	Parameter	Value	Unit
V _{GS}	Gate-source voltage	± 25	V
۱ _D	Drain current (continuous) at T _C = 25 °C	5.5 ⁽¹⁾	Α
I _D	Drain current (continuous) at T _C = 100 °C	3.6 ⁽¹⁾	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	22 ⁽¹⁾	Α
P _{TOT}	Total dissipation at T_{C} = 25 °C	20	W
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T_C =25 °C)	2500	v
dv/dt ⁽²⁾	Peak diode recovery voltage slope	15	V/ns
dv/dt ⁽³⁾	MOSFET dv/dt ruggedness	50	v/115
T _{stg}	Storage temperature	- 55 to 150	°C
Тj	Max. operating junction temperature	150	

Table 2. Absolute maximum ratings

1. Pulse width limited by safe operating area.

2. I_{SD} \leq 5.5 A, di/dt $\,\leq$ 400 A/ μ s; V_{DS peak} < V_(BR)DSS, V_DD=400 V

3. $V_{DS} \leq 480 V$

Table 3. Thermal data

Symbol	Symbol Parameter		Unit
R _{thj-case}	Thermal resistance junction-case max	6.25	°C/W
R _{thj-amb}	Thermal resistance junction-ambient max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I _{AR}	Avalanche current, repetetive or not repetetive (pulse width limited by T_{jmax})	2	А
E _{AS}	Single pulse avalanche energy (starting T _j =25°C, I _D = I _{AR} ; V _{DD} =50)	105	mJ



2 Electrical characteristics

(T_C = 25 °C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	I _D = 1 mA, V _{GS} = 0	600			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	V _{DS} = 600 V V _{DS} = 600 V, T _C =125 °C			1 100	μΑ μΑ
I _{GSS}	Gate-body leakage current (V _{DS} = 0)	V _{GS} = ± 25 V			±10	μA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	3	4	V
R _{DS(on)}	Static drain-source on-resistance	V _{GS} = 10 V, I _D = 3 A		0.72	0.78	Ω

Table 5. On /off states

Table	6.	Dynar	nic
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss}	Input capacitance		-	320	-	pF
C _{oss}	Output capacitance	V _{DS} = 100 V, f = 1 MHz,	-	18	-	pF
C _{rss}	Reverse transfer capacitance	V _{GS} = 0	-	0.68	-	pF
Coss eq.(1)	Equivalent output capacitance	$V_{DS} = 0$ to 480 V, $V_{GS} = 0$	-	88	-	pF
R _G	Intrinsic gate resistance	f = 1 MHz open drain	-	6.5	-	Ω
Qg	Total gate charge	V _{DD} = 480 V, I _D = 5.5 A,	-	10	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 10 V	-	2	-	nC
Q _{gd}	Gate-drain charge	(see Figure 15)	-	5.1	-	nC

1. Coss eq. is defined as a constant equivalent capacitance giving the same charging time as Coss when VDS increases from 0 to 80% VDSS

Table	7.	Switching	times
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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time		-	8.8	-	ns
t _r	Rise time	$V_{DD} = 300 \text{ V}, I_D = 3 \text{ A},$ $R_G = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 14 and Figure 19)	-	7.5	-	ns
t _{d(off)}	Turn-off delay time		-	22	-	ns
t _f	Fall time		-	13.5	-	ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		5.5	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		22	А
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 5.5 A, V _{GS} = 0	-		1.6	V
t _{rr}	Reverse recovery time		-	265		ns
Q _{rr}	Reverse recovery charge	$I_{SD} = 5.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 60 \text{ V} (\text{see Figure 16})$	-	1.65		μC
I _{RRM}	Reverse recovery current		-	12.5		Α
t _{rr}	Reverse recovery time	I _{SD} = 5.5 A, di/dt = 100 A/μs	-	377		ns
Q _{rr}	Reverse recovery charge	V _{DD} = 60 V, T _j = 150 °C	-	2.3		μC
I _{RRM}	Reverse recovery current	(see Figure 16)	-	12.2		Α

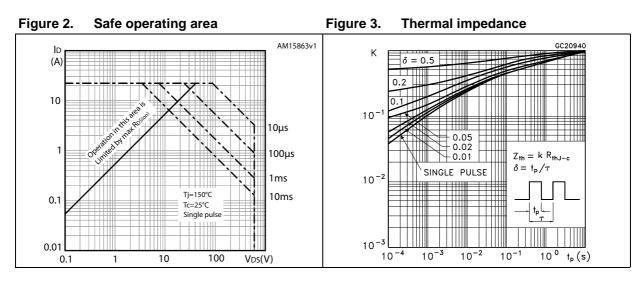
Table 8. Source drain diode

1. Pulse width limited by safe operating area.

2. Pulsed: pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)





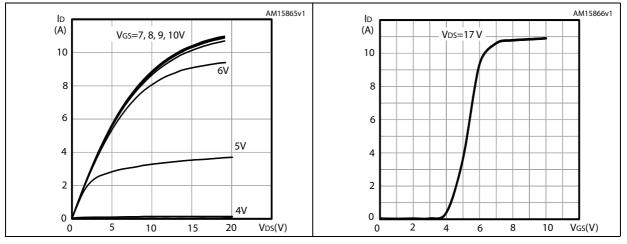
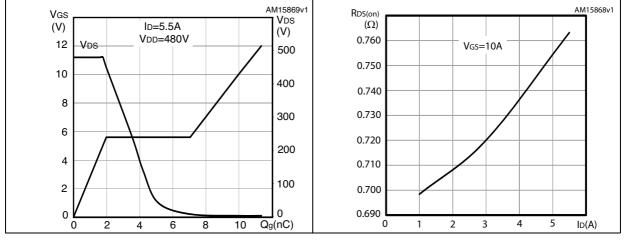


Figure 5.

Transfer characteristics







AM15872v1

TJ(°C)

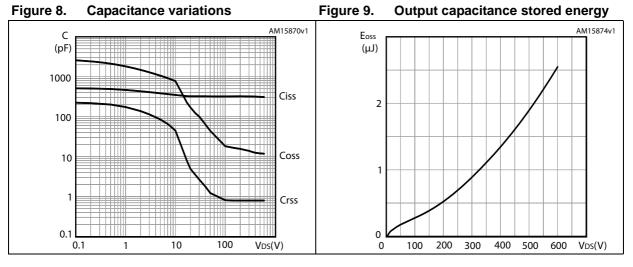


Figure 10. Normalized gate threshold voltage Figure 11. Normalized on-resistance vs vs temperature

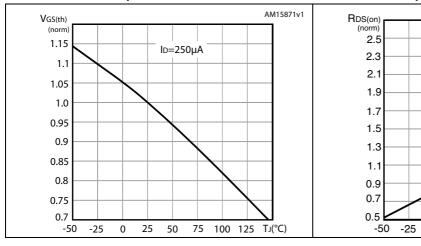
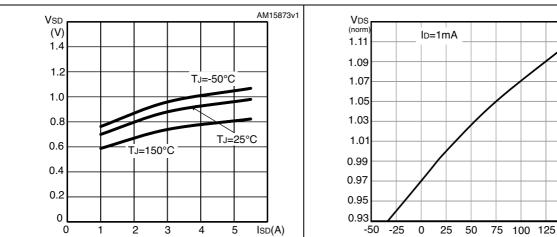
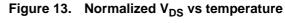


Figure 12. Source-drain diode forward characteristics





0

25

50 75 100 125

temperature

ID=3 A

VGS=10 V

AM15867v1 TJ(°C)



3 **Test circuits**

Figure 14. Switching times test circuit for resistive load

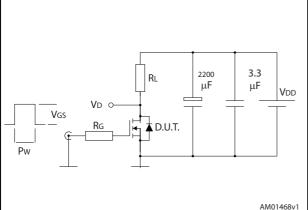


Figure 16. Test circuit for inductive load switching and diode recovery times

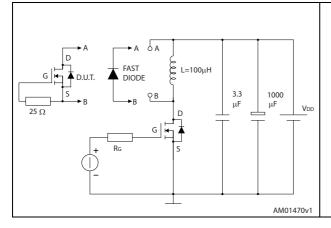


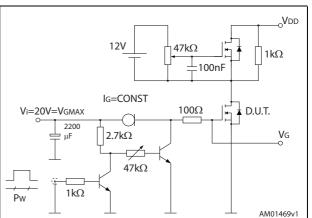
Figure 18. Unclamped inductive waveform

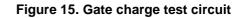
VD

ldм

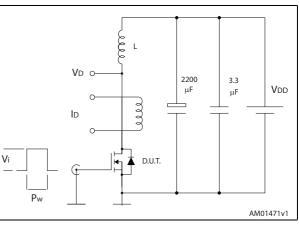
ID

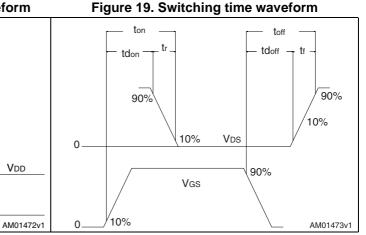
V(BR)DSS













Vdd

Vdd

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

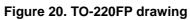


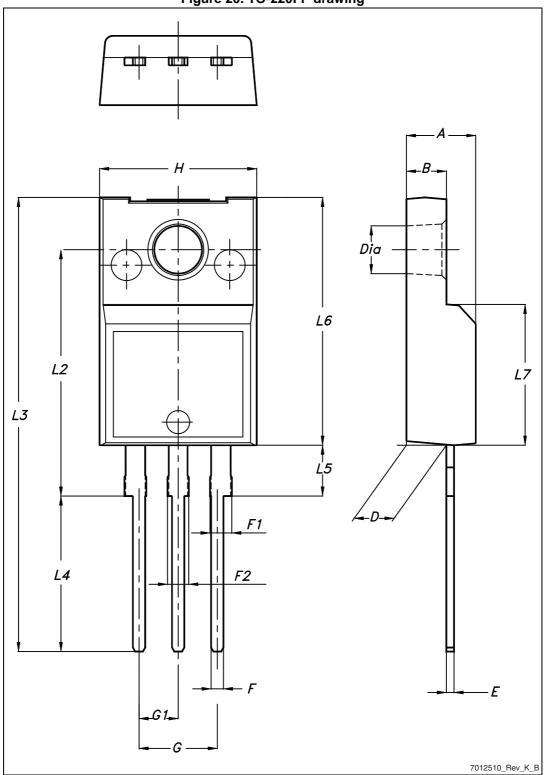
Package mechanical data

Table 9. TO-220FP mechanical data				
Dim.	mm			
	Min.	Тур.	Max.	
А	4.4		4.6	
В	2.5		2.7	
D	2.5		2.75	
Е	0.45		0.7	
F	0.75		1	
F1	1.15		1.70	
F2	1.15		1.70	
G	4.95		5.2	
G1	2.4		2.7	
Н	10		10.4	
L2		16		
L3	28.6		30.6	
L4	9.8		10.6	
L5	2.9		3.6	
L6	15.9		16.4	
L7	9		9.3	
Dia	3		3.2	

Table 9. TO-220FP mechanical data









5 Revision history

Date	Revision	Changes	
03-Jun-2013	1	First release.The part number was previously included in datasheet DocID024399.	



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